Listing of Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Claim 1 (currently amended) A memory pumping circuit comprising:

a DRAM cell used as <u>a</u> the-charging capacitor of said <u>memory</u> pumping circuit for enhancing the capacitance;

a current source coupled to the DRAM cell for providing a charge current to the DRAM cell; and

a node located between the current source and the DRAM cell for providing a pumping voltage used as a voltage source of a word line.

Claim 2 (currently amended) The memory pumping circuit according to Claim 1 wherein said DRAM cell <u>comprises consists of a MOS</u> transistor and a storage <u>cell-capacitor</u>.

Claim 3-5 (canceled)

Claim 6 (currently amended) The memory pumping circuit according to Claim 1 wherein , further comprising a driving circuit for generating generates a clock signal for driving said to drive the DRAM cell.

Claim 7 (original) The memory pumping circuit according to Claim 6 wherein said driving circuit is an inverter.

Claim 8 (currently amended) The memory pumping circuit according to Claim 6 wherein said driving circuit consists of comprises a PMOS transistor and a NMOS transistor, and generates said clock signal according to a first clock signal and a second clock signal.

Claim 9 (currently amended) A memory pumping circuit comprises:

a current source for providing a charge current;

a DRAM cell as a charging capacitor of the pumping circuit, said DRAM cell having an output port for providing a pumping voltage source used as a voltage source of a word line, said output port connecting to said coupled to the current source for receiving the charge current; and

a driving circuit for generating a first clock signal to said DRAM cell for driving said DRAM cell.

Claim 10 (currently amended) The memory pumping circuit according to Claim 9 wherein said DRAM cell <u>comprises consists of a MOS</u> transistor and a storage cell capacitor,

Claim 11 (canceled)

Claim 12 (original) The memory pumping circuit according to Claim 9 wherein said driving circuit is an inverter.

Claim 13 (currently amended) The memory pumping circuit according to Claim 9 wherein said driving circuit consists of comprises a PMOS transistor and a NMOS transistor, and generates said first clock signal according to a second clock signal and a third clock signal.